

# DS25BR150 3.125 Gbps LVDS Buffer

Check for Samples: DS25BR150

## **FEATURES**

- DC 3.125 Gbps Low Jitter, High Noise **Immunity, Low Power Operation**
- On-Chip 100 Ω Input and Output Termination Minimizes Insertion and Return Losses. **Reduces Component Count and Minimizes Board Space**
- 7 kV ESD on LVDS I/O Pins Protects Adjoining Components

Small 3 mm x 3 mm WSON-8 Space Saving Package

#### APPLICATIONS

- Clock or Data Buffering / Repeating
- OC-48 / STM-16 Clock or Data Buffering / Repeating
- **InfiniBand**
- **FireWire**

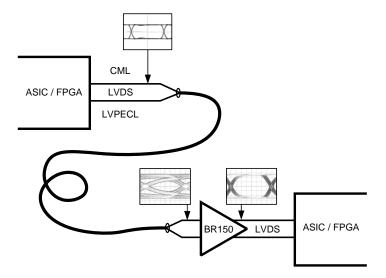
## **DESCRIPTION**

The DS25BR150 is a single channel 3.125 Gbps LVDS buffer optimized for high-speed signal transmission over printed circuit boards and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity.

The DS25BR150 is a buffer/repeater with very low power consumption. Other LVDS devices with similar IO characteristics and with signal conditioning features include the following products. The DS25BR110 features four levels of equalization for use as an optimized receiver device, the DS25BR120 features four levels of preemphasis for use as an optimized driver device, and the DS25BR100 features both pre-emphasis and equalization for use as an optimized repeater device.

Wide input common mode range allows the receiver to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flowthrough pinout allows easy board layout. The differential inputs and outputs are internally terminated with a  $100\Omega$ resistor to lower device input and output return losses, reduce component count, and further minimize board space.

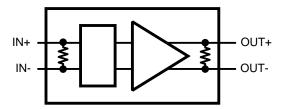
# **Typical Application**



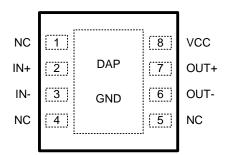
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## **Block Diagram**



# Pin Diagram



## **PIN DESCRIPTIONS**

Pin Name	Pin Name	Pin Type	Pin Description
NC	1	NA	"NO CONNECT" pin.
IN+	2	Input	Non-inverting LVDS input pin.
IN-	3	Input	Inverting LVDS input pin.
NC	4	NA	"NO CONNECT" pin.
NC	5	NA	"NO CONNECT" pin.
OUT-	6	Output	Inverting LVDS output pin.
OUT+	7	Output	Non-inverting LVDS Output pin.
VCC	8	Power	Power supply pin.
GND	DAP	Power	Ground pad (DAP - die attach pad)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

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# Absolute Maximum Ratings (1)(2)

Supply Voltage (V <sub>CC</sub> )	-0.3V to +4V
LVDS Input Voltage (IN+, IN−)	−0.3V to +4V
Differential Input Voltage  VID	1V
LVDS Output Voltage (OUT+, OUT-)	$-0.3V$ to $(V_{CC} + 0.3V)$
LVDS Differential Output Voltage ((OUT+) - (OUT-))	0V to 1V
LVDS Output Short Circuit Current Duration	5 ms
Junction Temperature	+150°C
Storage Temperature Range	−65°C to +150°C
Lead Temperature Range	
Soldering (4 sec.)	+260°C
Maximum Package Power Dissipation at 25°C	
NGQ0008A Package	2.08W
Derate NGQ0008A Package	16.7 mW/°C above +25°C
Package Thermal Resistance	
$\theta_{JA}$	+60.0°C/W
$\theta_{ extsf{JC}}$	+12.3°C/W
ESD Susceptibility	
HBM <sup>(3)</sup>	≥7 kV
MM <sup>(4)</sup>	≥250V
CDM <sup>(5)</sup>	≥1250V

<sup>(1) &</sup>quot;Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.

- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications.
- 3) Human Body Model, applicable std. JESD22-A114C
- (4) Machine Model, applicable std. JESD22-A115-A
- (5) Field Induced Charge Device Model, applicable std. JESD22-C101-C

### Recommended Operating Conditions

	Min	Тур	Max	Units
Supply Voltage (V <sub>CC</sub> )	3.0	3.3	3.6	V
Receiver Differential Input Voltage (V <sub>ID</sub> )	0		1	V
Operating Free Air Temperature (T <sub>A</sub> )	-40	+25	+85	°C

### **DC Electrical Characteristics**

Over recommended operating supply and temperature ranges unless otherwise specified. (1) (2) (3)

Symbol	Parameter	Min	Тур	Max	Units	
LVDS O	UTPUT DC SPECIFICATIONS (OUT+, OUT-)	•			•	,
V <sub>OD</sub>	Differential Output Voltage		250	350	450	mV
$\Delta V_{OD}$	Change in Magnitude of V <sub>OD</sub> for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV
Vos	Offset Voltage		1.05	1.2	1.375	V
ΔV <sub>OS</sub>	Change in Magnitude of V <sub>OS</sub> for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV

- (1) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.
- (2) Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except V<sub>OD</sub> and ΔV<sub>OD</sub>.
- (3) Typical values represent most likely parametric norms for V<sub>CC</sub> = +3.3V and T<sub>A</sub> = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

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## **DC Electrical Characteristics (continued)**

Over recommended operating supply and temperature ranges unless otherwise specified. (1) (2) (3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Ios	Output Short Circuit Current (4)	OUT to GND		-25	-50	mA
		OUT to V <sub>CC</sub>		7.5	50	mA
C <sub>OUT</sub>	Output Capacitance	Any LVDS Output Pin to GND		1.2		pF
R <sub>OUT</sub>	Output Termination Resistor	Between OUT+ and OUT-		100		Ω
LVDS IN	IPUT DC SPECIFICATIONS (IN+, IN-)					
V <sub>ID</sub>	Input Differential Voltage		0		1	V
$V_{TH}$	Differential Input High Threshold	$V_{CM} = +0.05V \text{ or } V_{CC}-0.05V$		0	+100	mV
$V_{TL}$	Differential Input Low Threshold		-100	0		mV
$V_{CMR}$	Common Mode Voltage Range	V <sub>ID</sub> = 100 mV	0.05		V <sub>CC</sub> - 0.05	V
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 3.6V or 0V V <sub>CC</sub> = 3.6V or 0V		±1	±10	μΑ
C <sub>IN</sub>	Input Capacitance	Any LVDS Input Pin to GND		1.7		pF
R <sub>IN</sub>	Input Termination Resistor	Between IN+ and IN-		100		Ω
SUPPLY	CURRENT		•	•	•	
I <sub>CC</sub>	Supply Current			27	35	mA

<sup>(4)</sup> Output short circuit current (I<sub>OS</sub>) is specified as magnitude only, minus sign indicates direction only.

### AC Electrical Characteristics (1)

Over recommended operating supply and temperature ranges unless otherwise specified. (2) (3)

Symbol	Parameter Condi		ditions	Min	Тур	Max	Units
LVDS O	UTPUT AC SPECIFICATIONS (OUT+, OUT-)						
t <sub>PHLD</sub>	Differential Propagation Delay High to Low	D 4000			370	520	ps
t <sub>PLHD</sub>	Differential Propagation Delay Low to High	$R_L = 100\Omega$		355	520	ps	
t <sub>SKD1</sub>	Pulse Skew  t <sub>PLHD</sub> - t <sub>PHLD</sub>   (4)				15	100	ps
t <sub>SKD2</sub>	Part to Part Skew (5)				45	160	ps
t <sub>LHT</sub>	Rise Time	D 4000	B 4000			150	ps
t <sub>HLT</sub>	Fall Time	$R_L = 100\Omega$		80	150	ps	
JITTER	PERFORMANCE (Figure 5)						
t <sub>DJ1</sub>	Deterministic Jitter (Peak-to-Peak Value )	V <sub>ID</sub> = 350 mV	2.5 Gbps		11	33	ps
t <sub>DJ2</sub>	(6)	V <sub>CM</sub> = 1.2V K28.5 (NRZ)	3.125 Gbps		15	41	ps
t <sub>RJ1</sub>	Random Jitter (RMS Value)	V <sub>ID</sub> = 350 mV	1.25 GHz		0.5	1	ps
t <sub>RJ2</sub>	(7)	V <sub>CM</sub> = 1.2V Clock (RZ)	1.5625 GHz		0.5	1	ps
t <sub>TJ1</sub>	Total Jitter (Peak to Peak Value)	$V_{ID} = 350 \text{ mV}$	2.5 Gbps		0.04	0.11	UI <sub>P-P</sub>
t <sub>TJ2</sub>	(8)	$V_{CM} = 1.2V$ PRBS-23 (NRZ)	3.125 Gbps		0.07	0.15	UI <sub>P-P</sub>

- (1) Specification is guaranteed by characterization and is not tested in production.
- (2) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.
- (3) Typical values represent most likely parametric norms for V<sub>CC</sub> = +3.3V and T<sub>A</sub> = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.
- (4) t<sub>SKD1</sub>, |t<sub>PLHD</sub> t<sub>PHLD</sub>|, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.
- (5) t<sub>SKD2</sub>, Part to Part Skew, is defined as the difference between the minimum and maximum specified differential propagation delays. This specification applies to devices at the same V<sub>CC</sub> and within 5°C of each other within the operating temperature range.
  (6) Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is
- (6) Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.
- (7) Measured on a clock edge with a histogram and an accumulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.
- (8) Measured on an eye diagram with a histogram and an accumulation of 3500 histogram hits. Input stimulus jitter is subtracted.



## **DC TEST CIRCUITS**

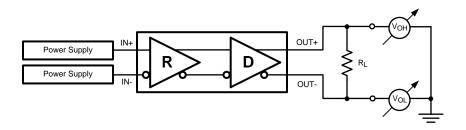


Figure 1. Differential Driver DC Test Circuit

# **AC Test Circuits and Timing Diagrams**

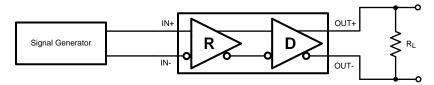


Figure 2. Differential Driver AC Test Circuit

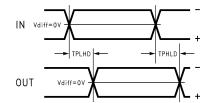


Figure 3. Propagation Delay Timing Diagram

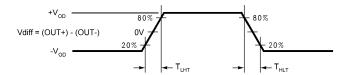


Figure 4. LVDS Output Transition Times

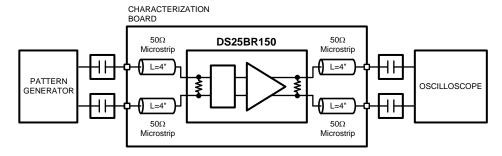


Figure 5. Jitter Measurements Test Circuit

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## **Device Operation**

### INPUT INTERFACING

The DS25BR150 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS25BR150 can be DC-coupled with all common differential drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers. Note that the DS25BR150 inputs are internally terminated with a  $100\Omega$  resistor.

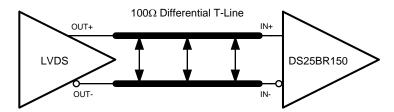


Figure 6. Typical LVDS Driver DC-Coupled Interface to DS25BR150 Input

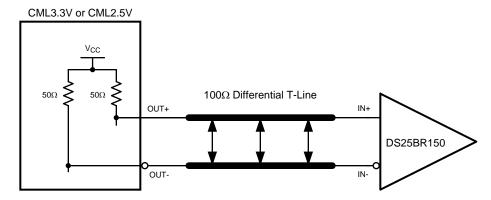


Figure 7. Typical CML Driver DC-Coupled Interface to DS25BR150 Input

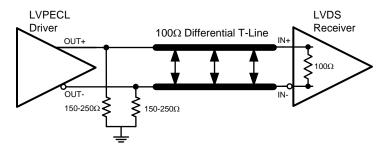


Figure 8. Typical LVPECL Driver DC-Coupled Interface to DS25BR150 Input

#### **OUTPUT INTERFACING**

The DS25BR150 outputs signals are compliant to the LVDS standard. It can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accommodate LVDS compliant signals, it is recommended to check the respective receiver's data sheet prior to implementing the suggested interface implementation.



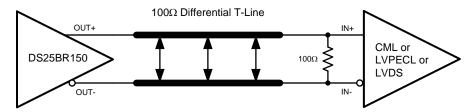
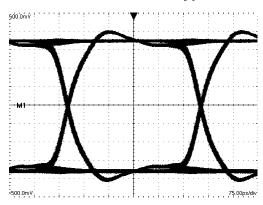


Figure 9. Typical DS25BR150 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver



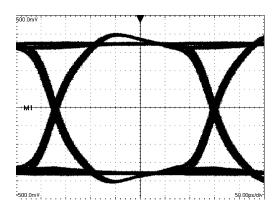
# **Typical Performance Characteristics**



 $V_{CC} = 3.3V$  $T_A = 25$ °C TOTAL RESIDUAL JITTER (ps) 50 NRZ PRBS-7 2.5 Gbps 40  $V_{ICM} = 1.0V$ 30 20  $V_{ICM} = 2.4V$ 10 0.25 0.40 0.55 0.70 0.85 1.00 DIFFERENTIAL INPUT VOLTAGE (V)

Figure 10. A 2.5 Gbps NRZ PRBS-7 Output Eye Diagram V:100 mV / DIV, H:75 ps / DIV

Figure 11. Total Jitter as a Function of Input Amplitude



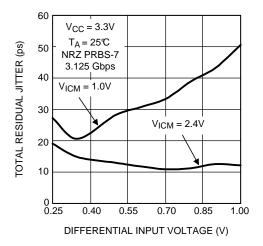


Figure 12. A 3.125 Gbps NRZ PRBS-7 Output Eye Diagram V:100 mV / DIV, H:50 ps / DIV

Figure 13. Total Jitter as a Function of Input Amplitude



# PACKAGE OPTION ADDENDUM

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#### **PACKAGING INFORMATION**

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Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish		Op Temp (°C)	3	Samples
DS25BR150TSD/NOPB	ACTIVE	WSON	NGQ	8	1000	Green (RoHS & no Sb/Br)	CU SN	(3) Level-3-260C-168 HR	-40 to 85	2R150	Samples
DS25BR150TSDX/NOPB	ACTIVE	WSON	NGQ	8	4500	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	-40 to 85	2R150	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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<sup>&</sup>lt;sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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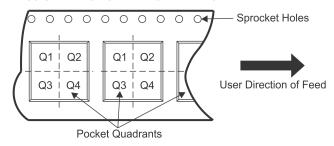
# TAPE AND REEL INFORMATION





_		
		Dimension designed to accommodate the component width
	В0	Dimension designed to accommodate the component length
	K0	Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ı	P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS25BR150TSD/NOPB	WSON	NGQ	8	1000	178.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1
DS25BR150TSDX/NOPB	WSON	NGQ	8	4500	330.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1

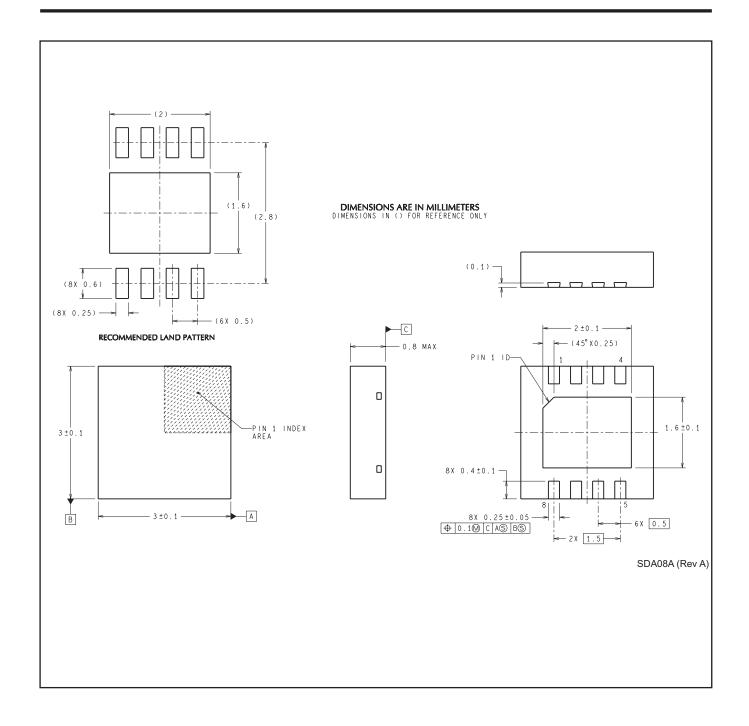
# **PACKAGE MATERIALS INFORMATION**

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#### \*All dimensions are nominal

Device	Package Type Package Drawing		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS25BR150TSD/NOPB	WSON	NGQ	8	1000	213.0	191.0	55.0
DS25BR150TSDX/NOPB	WSON	NGQ	8	4500	367.0	367.0	35.0



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